Se	arcn No	res

Application/Cont	roi No.	Applicant(s) Reexaminat	/Patent under
10/698,502		MEYER-FR MICHELE	
Examiner		Art Unit	
Stephen J. Stein		1775	

SEARCHED			
Class	Subclass	Date	Examiner
428	34.1	3/30/2005	sus
428	34.4	3/30/2005	sjs
428	408	3/30/2005	SJS
Updated	Search	9/20/2005	SJS
428	304.4	9/20/2005	SJS
toa	lato	3/06	MC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<del></del>			
			<del>                                     </del>
L			

SEARCH NO (INCLUDING SEARCH		)
·	DATE	EXMR
West Search (Derwent/EPO/JPO) (USPAT/PGPUBS)	3/30/2005	sıs
Inventor Search (Reviewed Parent application and related co-invented applications)	3/30/2005	sıs
•		